

## Description:

This N+P Channel MOSFET uses advanced trench technology and

design to provide excellent  $R_{DS(on)}$  with low gate charge.

It can be used in a wide variety of applications.

## Features:

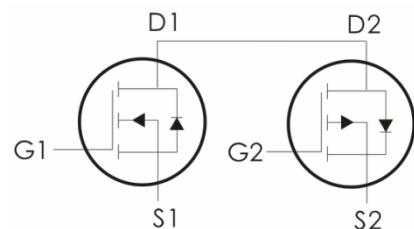
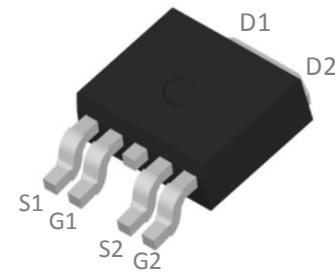
N-Channel:  $V_{DS}=40V, I_D=20A, R_{DS(ON)}<25m\Omega @ V_{GS}=10V$

$R_{DS(ON)}<35m\Omega @ V_{GS}=4.5V$

P-Channel:  $V_{DS}=-40V, I_D=-12A, R_{DS(ON)}<40m\Omega @ V_{GS}=10V$

$R_{DS(ON)}<52m\Omega @ V_{GS}=4.5V$

- 1) Low gate charge.
- 2) Green device available.
- 3) Advanced high cell density trench technology for ultra low  $R_{DS(ON)}$ .
- 4) Excellent package for good heat dissipation.



## Absolute Maximum Ratings: ( $T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	N-Channel	P-Channel	Units
$V_{DS}$	Drain-Source Voltage	40	-40	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V
$I_D$	Continuous Drain Current- $T_c=25^\circ C$	20	-12	A
	Continuous Drain Current- $T_c=100^\circ C$	12	-7	
$I_{DM}$	Pulsed Drain Current <sup>note1</sup>	70	-48	A
$P_D$	Power Dissipation $T_c=25^\circ C$	28	20	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	$-55$ to $+150$		°C

## Thermal Characteristics:

Symbol	Parameter	Max		Units
		---	4.5	
$N \ R_{eJC}$	Thermal Resistance,Junction to Case <sup>1</sup>	---	6	°C/W
$P \ R_{eJC}$	Thermal Resistance,Junction to Case <sup>1</sup>			

## Package Marking and Ordering Information:

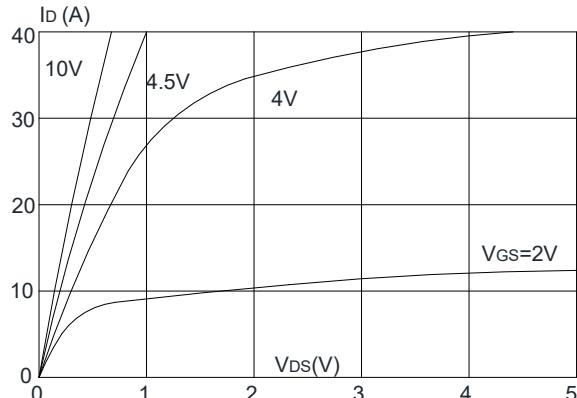
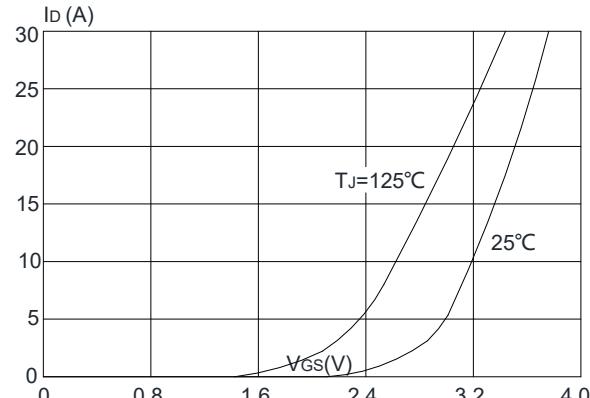
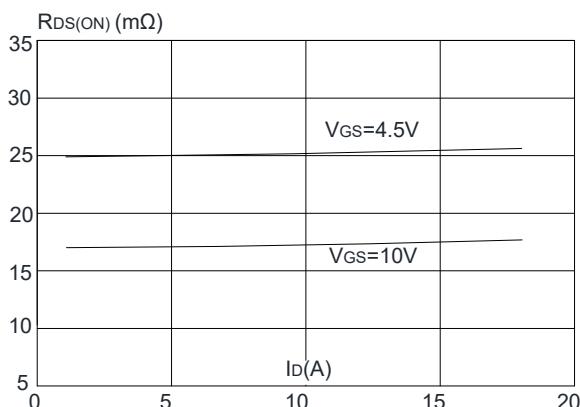
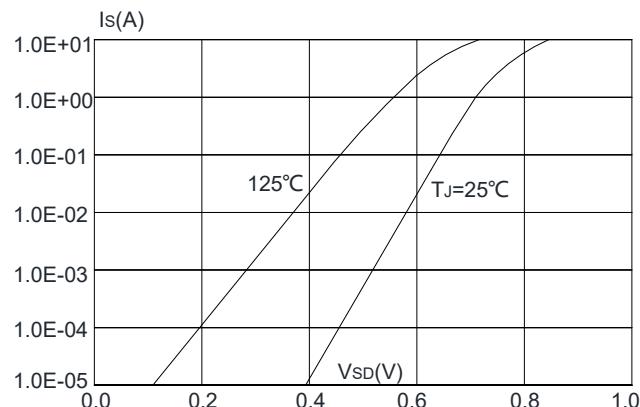
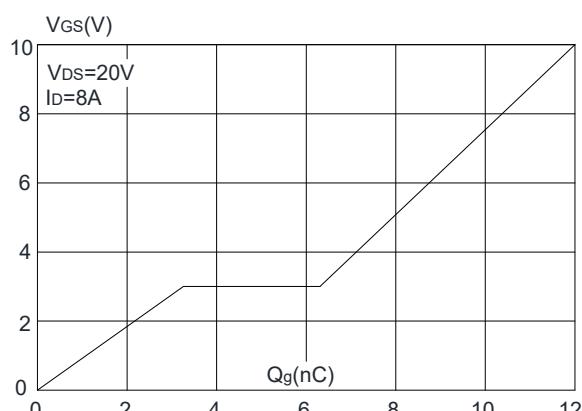
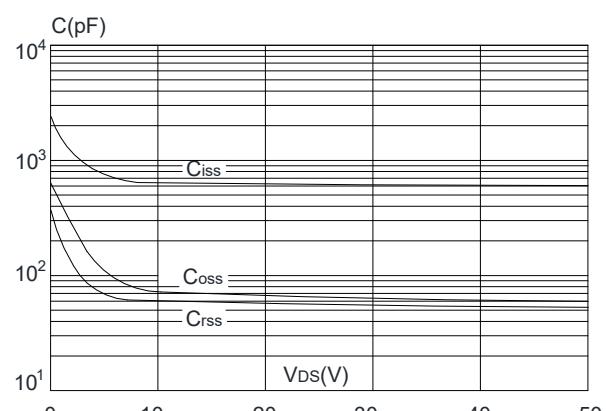
Part NO.	Marking	Package
DOD609D	D609D	TO-252-4

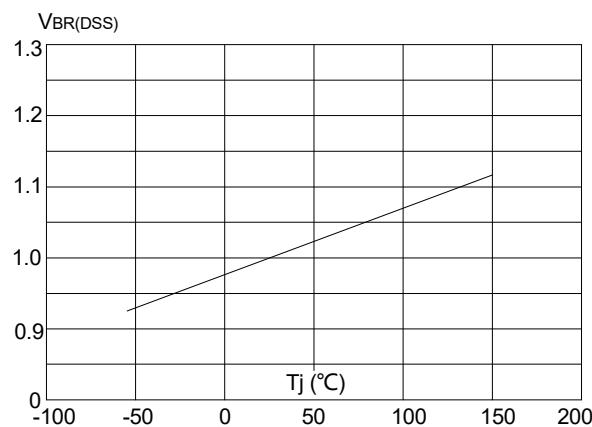
## N-CH Electrical Characteristics: ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	40	---	---	V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=400\text{V}$	---	---	1	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	$\pm 100$	nA
<b>On Characteristics<sup>3</sup></b>						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	1	1.5	2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=8\text{A}$	---	17	25	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=5\text{A}$	---	25	35	
<b>Dynamic Characteristics<sup>4</sup></b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=20\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	620	---	pF
$C_{\text{oss}}$	Output Capacitance		---	65	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	55	---	
<b>Switching Characteristics<sup>4</sup></b>						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DS}}=20\text{V}, R_{\text{L}}=2.5 \Omega$ $R_{\text{GEN}}=3 \Omega, V_{\text{GS}}=10\text{V}$	---	4	---	ns
$t_r$	Rise Time <sup>2,3</sup>		---	3	---	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time <sup>2,3</sup>		---	15	---	ns
$t_f$	Fall Time <sup>2,3</sup>		---	2	---	ns
$Q_g$	Total Gate Charge <sup>2,3</sup>	$V_{\text{GS}}=8\text{V}, V_{\text{DS}}=20\text{V}, I_{\text{D}}=10\text{A}$	---	12	---	nC
$Q_{\text{gs}}$	Gate-Source Charge <sup>2,3</sup>		---	3.2	---	nC
$Q_{\text{gd}}$	Gate-Drain "Miller" Charge <sup>2,3</sup>		---	3.1	---	nC
<b>Drain-Source Diode Characteristics</b>						
$V_{\text{SD}}$	Drain Diode Forward Voltage <sup>3</sup>	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=3\text{A}$	---	---	1.2	V
$I_{\text{S}}$	Continuous Source Current	$V_G=V_D=0\text{V}$ Force Current	---	---	20	A

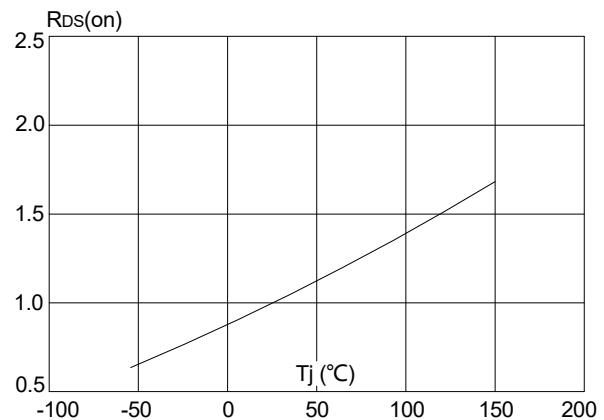
**Notes:**

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .
3. Essentially independent of operating temperature.

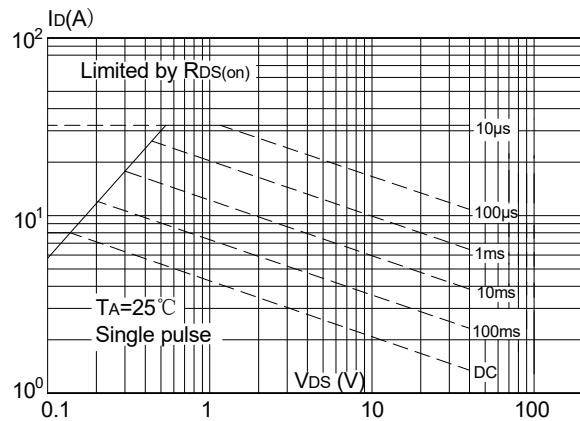
**Typical Performance Characteristics-N**

**Figure 1:** Output Characteristics

**Figure 2:** Typical Transfer Characteristics

**Figure 3:** On-resistance vs. Drain Current

**Figure 4:** Body Diode Characteristics

**Figure 5:** Gate Charge Characteristics

**Figure 6:** Capacitance Characteristics



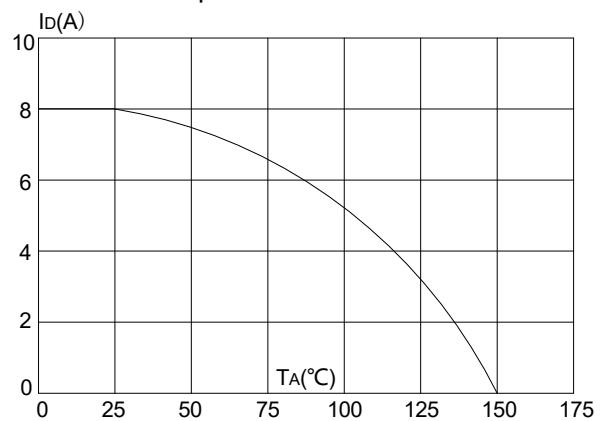
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



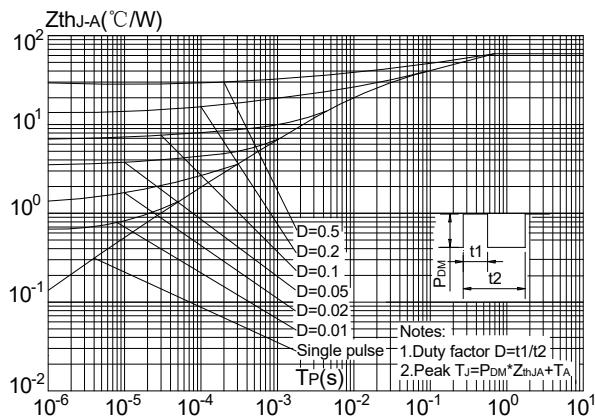
**Figure 8:** Normalized on Resistance vs. Junction Temperature



**Figure 9:** Maximum Safe Operating Area



**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature



**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

**P-CH Electrical Characteristics:** ( $T_C=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
<b>BV<sub>DSS</sub></b>	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250 \mu\text{A}$	-40	---	---	V
<b>I<sub>DSS</sub></b>	Zero Gate Voltage Drain Current	$V_{GS}=0\text{V}, V_{DS}=-40\text{V}$	---	---	-1	$\mu\text{A}$
<b>I<sub>GSS</sub></b>	Gate-Source Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{A}$	---	---	$\pm 100$	nA
<b>On Characteristics<sup>3</sup></b>						
<b>V<sub>GS(th)</sub></b>	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250 \mu\text{A}$	-1.2	-1.6	-2.5	V
<b>R<sub>DSON</sub></b>	Drain-Source On Resistance <sup>2</sup>	$V_{GS}=-10\text{V}, I_D=-5\text{A}$	---	30	40	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=-4\text{A}$	---	42	52	
<b>G<sub>Fs</sub></b>	Forward Transconductance	$V_{DS}=-10\text{V}, I_D=-3\text{A}$	---	9	---	S
<b>Dynamic Characteristics<sup>4</sup></b>						
<b>C<sub>iss</sub></b>	Input Capacitance	$V_{DS}=-15\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$	---	1020	1570	pF
<b>C<sub>oss</sub></b>	Output Capacitance		---	100	150	
<b>C<sub>rss</sub></b>	Reverse Transfer Capacitance		---	78	118	
<b>Switching Characteristics<sup>4</sup></b>						
<b>t<sub>d(on)</sub></b>	Turn-On Delay Time	$V_{DS}=-20\text{V}, I_D=-1\text{A}, R_{GEN}=25 \Omega, V_{GS}=-4.5\text{V}$	---	20	40	ns
<b>t<sub>r</sub></b>	Rise Time <sup>2,3</sup>		---	12	24	ns
<b>t<sub>d(off)</sub></b>	Turn-Off Delay Time <sup>2,3</sup>		---	46	80	ns
<b>t<sub>f</sub></b>	Fall Time <sup>2,3</sup>		---	6	12	ns
<b>Q<sub>g</sub></b>	Total Gate Charge <sup>2,3</sup>	$V_{GS}=-4.5\text{V}, V_{DS}=20\text{V}, I_D=-5\text{A}$	---	9	15	nC
<b>Q<sub>gs</sub></b>	Gate-Source Charge <sup>2,3</sup>		---	2.5	5	nC
<b>Q<sub>gd</sub></b>	Gate-Drain "Miller" Charge <sup>2,3</sup>		---	3.2	7	nC
<b>Drain-Source Diode Characteristics</b>						
<b>V<sub>SD</sub></b>	Source -Drain Diode Forward Voltage	$V_{GS}=0\text{V}, I_S=-1\text{A}$	---	---	-1.0	V
<b>I<sub>s</sub></b>	Continuous Source Current	$V_G=V_D=0\text{V}, \text{Force Current}$	---	---	-12	A
<b>I<sub>sm</sub></b>	Pulsed Source Current		---	---	-24	A

**Notes:**

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$ .
3. Essentially independent of operating temperature.

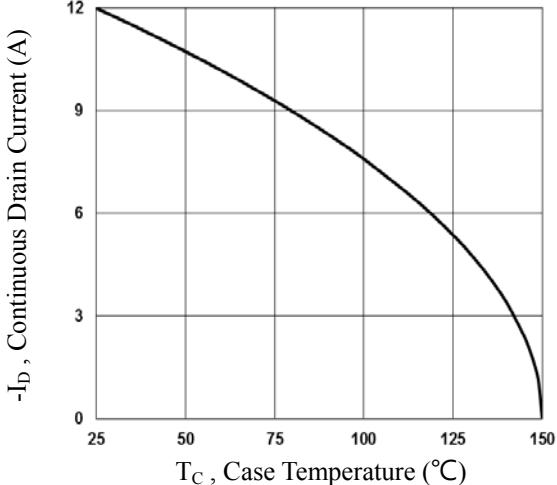
**Typical Performance Characteristics-P**


Fig.1 Continuous Drain Current vs.  $T_c$

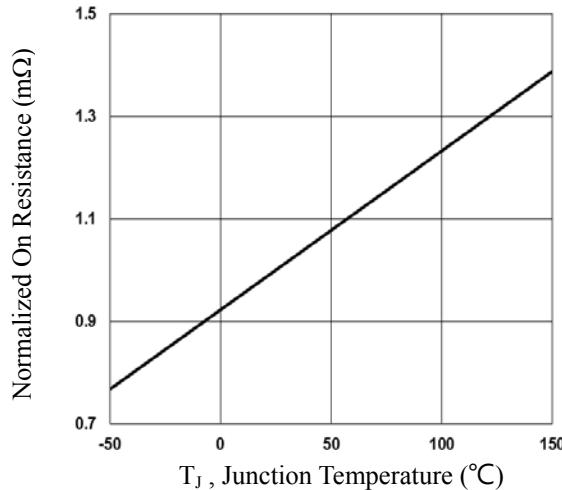


Fig.2 Normalized RDSON vs.  $T_j$

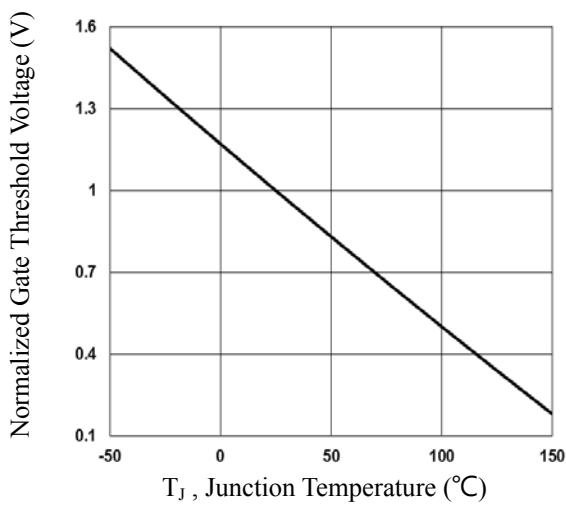


Fig.3 Normalized  $V_{th}$  vs.  $T_j$

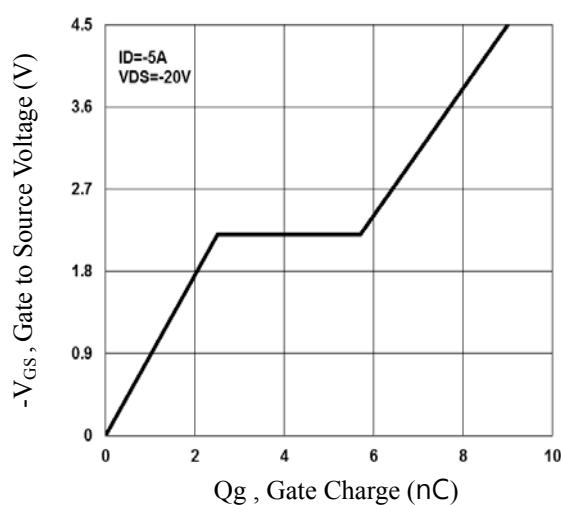


Fig.4 Gate Charge Waveform

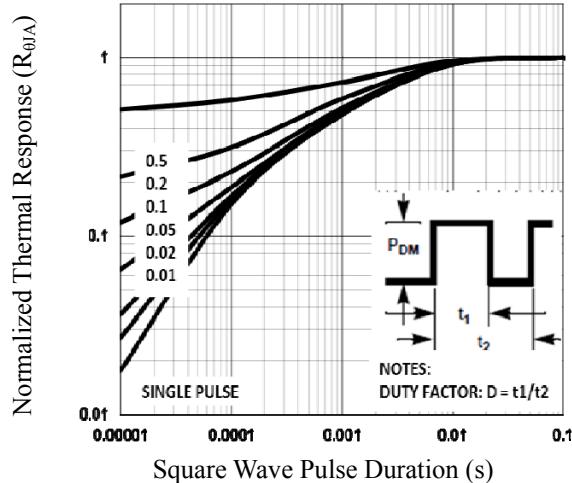


Fig.5 Normalized Transient Impedance

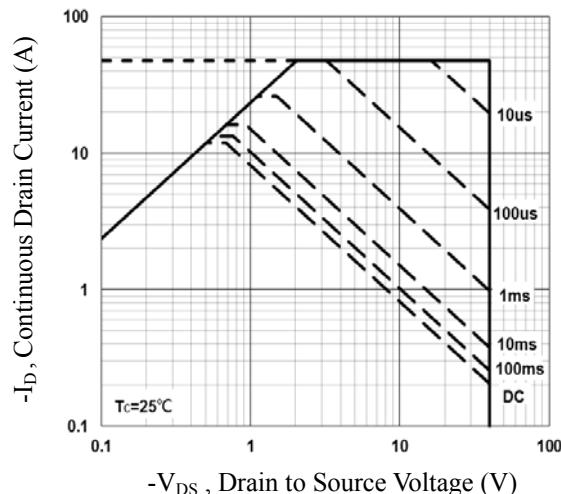


Fig.6 Maximum Safe Operation Area